

Preliminary

SIGC41T120R3

IGBT³ Chip

FEATURES:

- 1200V Trench + Field Stop technology
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

This chip is used for:

power module



Applications:

drives

Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC41T120R3	1200V	35A	6.5 x 6.37 mm ²	sawn on foil	Q67050- A4105-A001

MECHANICAL PARAMETER:

Raster size	6.5 x 6.37		
Emitter pad size	4.992 x 4.898		
Gate pad size	1.139 x 1.139		
Area total / active	41.4 / 30.1		
Thickness	140		
Wafer size	150	mm	
Flat position	180	grd	
Max.possible chips per wafer	350 pcs		
Passivation frontside	Photoimide		
Emitter metallization	3200 nm Al Si 1%		
Collector metallization	1400 nm Ni Ag -system suitable for epoxy and soft solder die bonding		
Die bond	electrically conductive glue or solder		
Wire bond	AI, <500μm		
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm		
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C		



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MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	I _C	35	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	70	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

STATIC CHARACTERISTICS (tested on chip), T_{j} =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
Tarameter			min.	typ.	max.	0
Collector-emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0 V , I_{C} = 1.5 mA	1200			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =35A	1.4	1.7	2.1	V
Gate-emitter threshold voltage	V _{GE(th)}	$I_C=1.5$ mA , $V_{GE}=V_{CE}$	5.0	5.8	6.5	
Zero gate voltage collector current	I _{CES}	V _{CE} =1200V , V _{GE} =0V			250	μA
Gate-emitter leakage current	I _{GES}	V _{CE} =0V , V _{GE} =30V			600	nA
Integrated gate resistor	R _{Gint}			6		Ω

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol Con	Conditions	Value			Unit
raiametei	Symbol	Conditions	min.	typ.	max.	Oilit
Input capacitance	Ciss	V _{CE} =25V,		2530		pF
Output capacitance	Coss	$V_{GE}=0V$,		132		
Reverse transfer capacitance	Crss	f=1MHz		115		

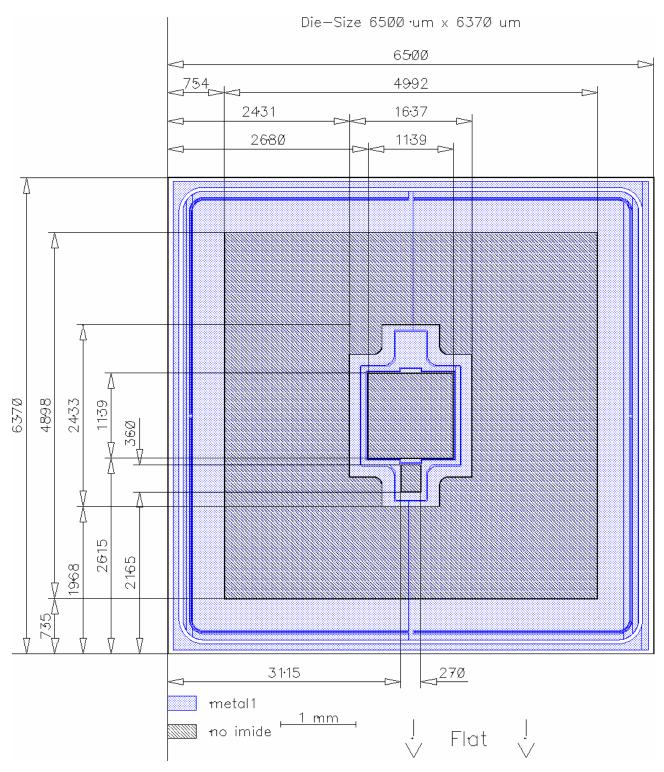
SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions	Value			Unit
	Symbol	Conditions	min.	typ.	max.	Oiiit
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =125°C		90		ns
Rise time	t _r	$V_{\rm CC} = 600 \text{V}$,		45		
Turn-off delay time	$t_{d(off)}$	I _C =35A, V _{GE} =-15/15V,		520		
Fall time	t _f	$R_{\rm G}$ = 27 Ω		90		



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CHIP DRAWING:





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FURTHER ELECTRICAL CHARACTERISTICS:						
This chip data sheet refers to the device data sheet	tbd					
DESCRIPTION:						
AQL 0,65 for visual inspection according to failu	ure catalog					
Electrostatic Discharge Sensitive Device accord	ding to MIL-STD 883					
Test-Norman Villach/Prüffeld						

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